Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/750,016	HOFFMAN ET AL.	
Examiner	Art Unit	
Jeff H. Aftergut	1733	

SEARCHED					
	· · · · · · · · · · · · · · · · · · ·				
Class	Subclass	Date	Examiner		
156	495, 496	2/22/2007	JHA		
156	229	2/22/2007	JHA		
		•			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		
·				
searc	SPAT text n- see nce search tout	3/22/2007	JHA	

(INCLUDING SEAR		
	DATE	EXMR
•		
	İ	
N		
•		
•		
<del>-</del>		
_		
•		